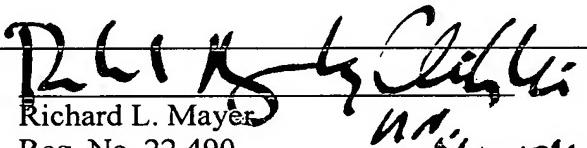


10/524783

DTIZ Rec'd PCT/PTO 16 FEB 2005

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			
<b>INFORMATION DISCLOSURE STATEMENT</b>		Docket Number 10191/3668	International Application No. PCT/DE03/02314
Application Serial No. To Be Assigned	International Filing Date July 10, 2003	Examiner To Be Assigned	Art Unit To Be Assigned
Title <b>METHOD AND DEVICE FOR FASTENING AND ALIGNING A SENSOR</b>		Inventor(s) Frank KURFISS et al.	
<p>Mail Stop PCT          Commissioner for Patents          P.O. Box 1450          Alexandria, Virginia 22313-1450</p> <p>1. In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and in conformance with the procedures of 37 C.F.R. §§ 1.97 and 1.98 and M.P.E.P. § 609, attorneys for Applicants hereby bring the references listed on the attached modified PTO form 1449 to the attention of the Examiner. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom. The filing of this Information Disclosure Statement and the enclosed PTO Form No. 1449, shall not be construed as an admission that the information cited is prior art, or is considered to be material to patentability as defined in 37 C.F.R. § 1.56(b).</p> <p>2. A copy of each patent, publication or other information listed on the modified PTO form 1449 is enclosed, except as otherwise indicated.</p>			
Dated: <u>Feb. 16, 2005</u>	By:	 Richard L. Mayer Reg. No. 22,490 KENYON & KENYON One Broadway New York, New York 10004 (212) 425-7200 (telephone) (212) 425-5288 (facsimile) <b>CUSTOMER NO. 26646</b>	

2V323019414

10/524783

DT12 Rec'd PCT/PTO 16 FEB 2005

<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO-1449</b>	Attorney Docket No. 10191/3668	Serial No. To Be Assigned
	Applicant(s) Frank KURFISS et al.	
	Filing Date Herewith	Group Art Unit To Be Assigned

**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE
	6,337,491*	January 8, 2002	Krieg et al.			
	5,589,026*	December 31, 1996	Perecman			
	2004/208497*	October 21, 2004	Seger et al.			

\* Copy not provided pursuant to Official Gazette Notice of August 5, 2003.

**FOREIGN PATENT DOCUMENTS**

EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	101 62 652**	July 3, 2003	DE				
	0 934 851*	August 11, 1999	EP				
	0 982 196*	March 1, 2000	EP				
	2001-197337*	July 19, 2001	JP				
	2002-207149*	July 26, 2002	JP				
	11-78716*	March 23, 1999	JP				
	40 40 579***	June 25, 1992	DE				
	198 27 044***	October 21, 1999	DE				
	696 03 598 T***	May 4, 2000	DE				

\* Listed in Search Report (copy not provided, copy provided by International Searching Authority).

\*\* Mentioned in Specification.

\*\*\* English-language abstract provided.

**OTHER DOCUMENTS**

EXAMINER'S INITIALS	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
	Patent Abstracts of Japan, Vol. 2002, No. 11, November 6, 2002*
	Patent Abstracts of Japan, Vol. 1999, No. 08, June 30, 1999*
	Patent Abstracts of Japan, Vol. 2000, No. 24, May 11, 2001*

\* Listed in Search Report (copy not provided, copy provided by International Searching Authority).

EXAMINER	DATE CONSIDERED
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	